

Notice of References Cited

Application/Control No.

10/629,033

Applicant(s)/Patent Under
Reexamination
MAYO ET AL.

Examiner

ERIC C. WAI

Art Unit

2195

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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2003/0149904	08-2003	Kim, Ju-Hun	713/330
	B	US-			
	C	US-			
	D	US-			
	E	US-			
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FOREIGN PATENT DOCUMENTS

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